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(12) **United States Design Patent**
Lei

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(54) **ANALYTE TEST STRIP PORT ICON**

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D24/133, 135, 138, 140, 145, 169, 191, 216-217,
D24/223-225, 227; D10/30-32, 38, 57,
D10/70, 78, 81, 98, 104; 606/87-88, 96,
606/102-103, 142, 151, 157-158, 213; 600/229;
403/56; 248/276.1, 288.51, 316.4; 29/229,
29/243.56, 268; 455/404.1; 227/902, 260;
D8/16, 19, 355; 24/510; 435/6, 287.2; D27/17,
D27/21; 204/403.01; 216/13, 17

See application file for complete search history.

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(57) **CLAIM**

The ornamental design for an analyte test strip port icon, as shown and described.

DESCRIPTION

FIG. 1 is one perspective view of the analyte test strip port icon, as viewed from a top position; and,

FIG. 2 is a top plan view thereof.

1 Claim, 1 Drawing Sheet

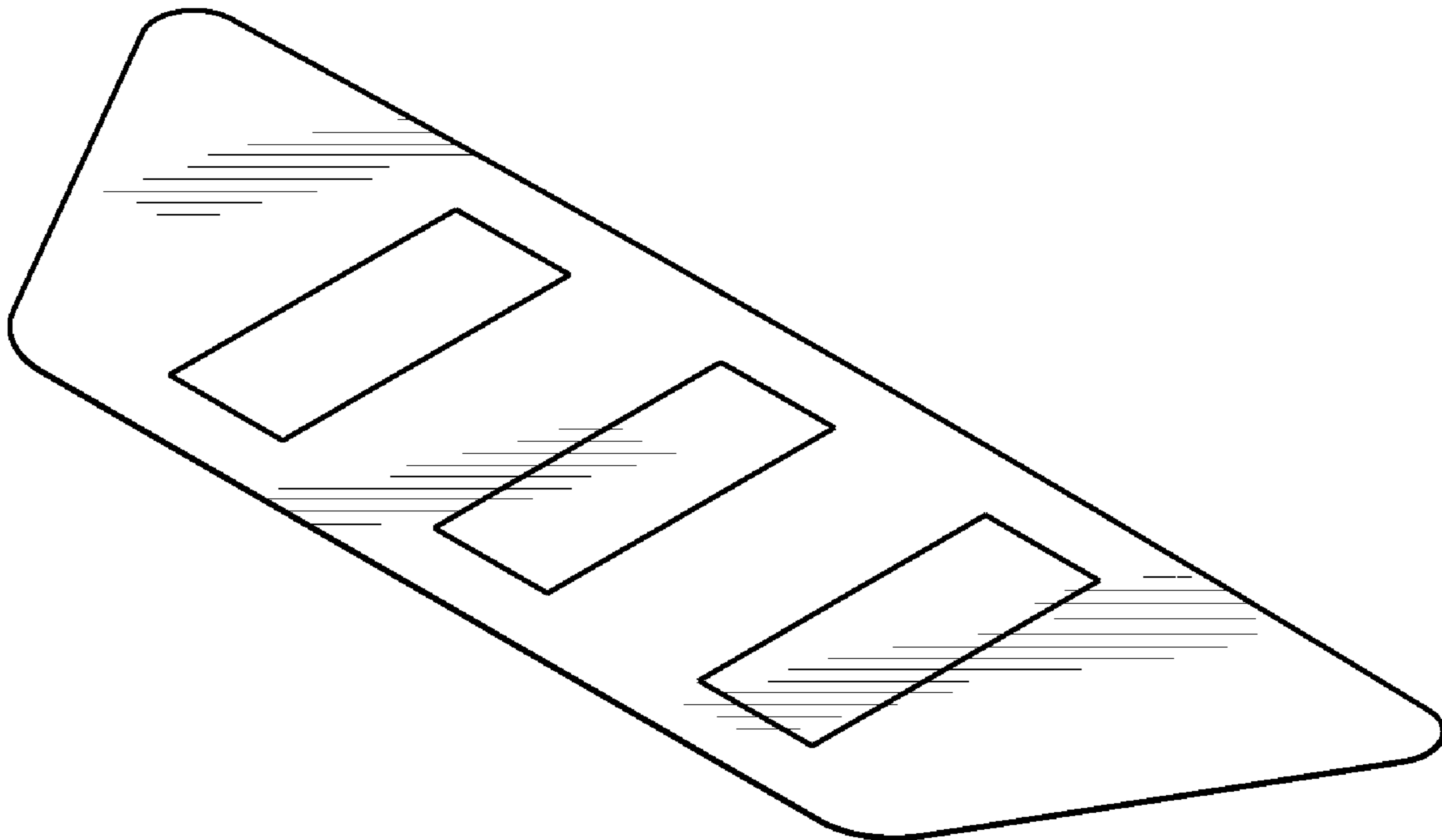


FIG. 1

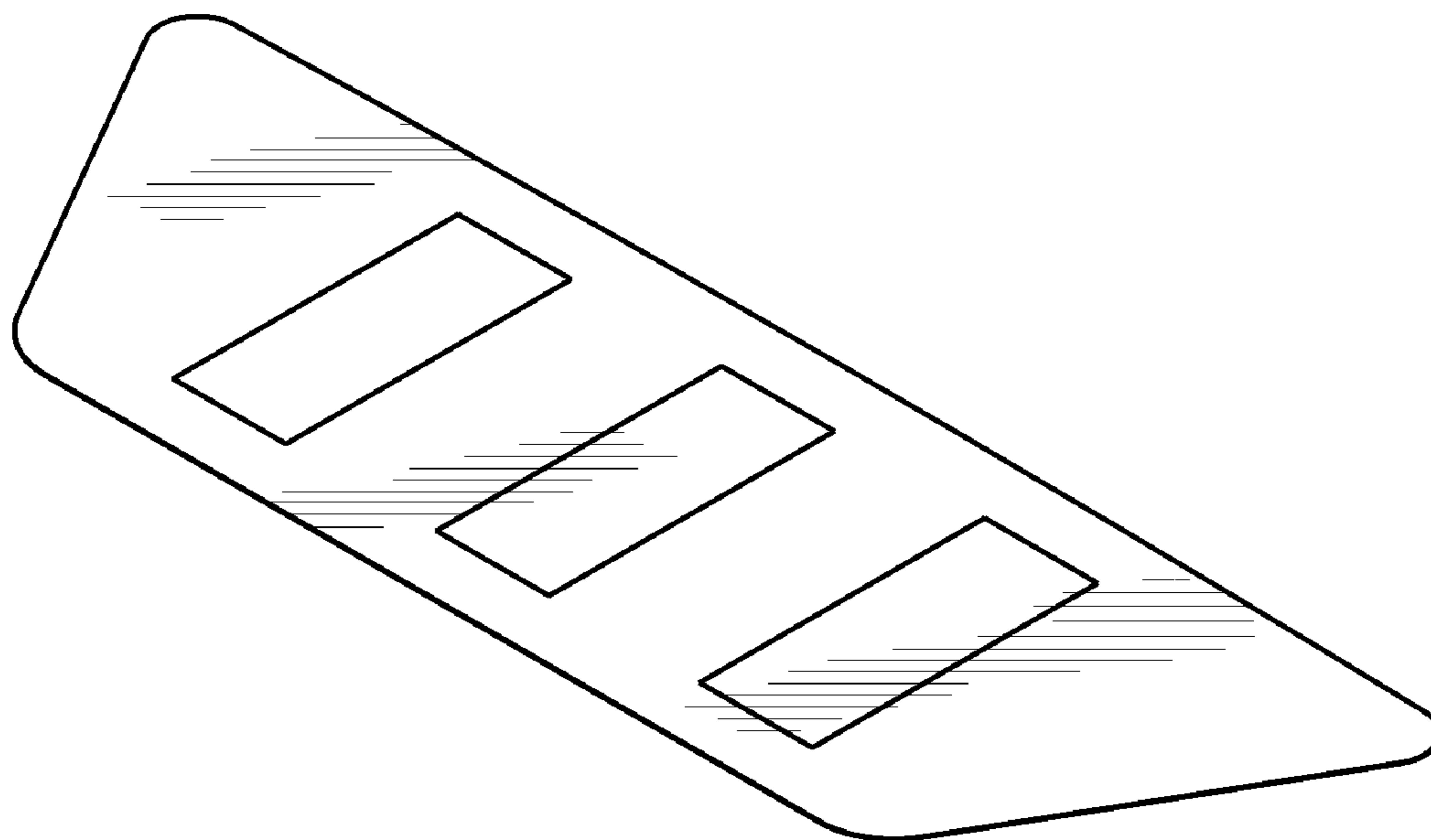


FIG. 2

